

Notice of References Cited

Application/Control No.

10/551,570

Applicant(s)/Patent Under
Reexamination
BEIL ET AL.

Examiner

David R. Crowe

Art Unit

2885

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0053072	12-2001	Takemoto, Takahiro	362/31
*	B	US-6,241,358	06-2001	Higuchi et al.	362/613
*	C	US-6,464,367	10-2002	Ito et al.	362/613
*	D	US-6,580,477	06-2003	Cho, Chun-Hyun	349/65
*	E	US-6,036,328	03-2000	Ohtsuki et al.	362/612
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.